Physics II.: Physics Process



Mihaly Novak (CERN, EP-SFT) Geant4 Tutorial at Lund University, Lund (Sweden), 3-7 September 2018 Geant4.10.4

Slides based on Dennis Wright (SLAC) & Vladimir Ivantchenko (CERN) lectures

OUTLINE

Overview of Geant4 physics components

The Geant4 physics process interface(es)

• G4VProcess interface and its specialisations

Secondary particle production thresholds

- o What is it? Why do we need them?
- An example.
- Production cuts per region.

Outline

PHYSICS COMPONENTS

- Overview of Geant4 physics components
- The Geant4 physics process interface(es)
- G4VProcess interface and its specialisations
- Secondary particle production thresholds
- What is it? Why do we need them?
- An example.
- Production cuts per region.





- Geant4 provides a vide variety of physics components
- The building blocks of these components are Processes:
 - o a process describes a well defined interaction of (a) particle(s) with matter
 - o describe = determines *when* the interaction happens and what the *result is*
 - processes provide these information through a G4VProcess interface (later)
 - Geant4 provides a huge number of such processes
- users might introduce their own process(es) easily by implementing the general process interface

Processes are classified as:

- Electromagnetic
- Hadronic
- o Decay
- Parameterized
- Transportation



Geant4 Physics: Electromagnetic

- the standard EM part: provides a complete set of EM interactions (processes) of charged particles and gammas from 1 keV to ~PeV
- the low energy EM part: includes special treatments for low energy e-/+, gammas and charged hadrons:
 - more sophisticated approximations valid down to lower energies e.g. more atomic shell structure details
 - some of these processes will be valid down to below keV but some can be used only up to few GeV
- *optical photons*: interactions special only for long wavelength photons
 - processes for reflection/refraction, absorption, wavelength shifting, (special) Rayleigh scattering

- Geant4 Physics: Hadronic
 - pure hadronic interactions for 0 to ~TeV
 - ◆ elastic, inelastic, capture, fission
 - o radioactive decay:
 - both at-rest and in-flight
 - photo-nuclear interaction from ~10 MeV up to ~TeV
 - lepto-nuclear interaction from ~10 MeV up to ~TeV
 - + e+ and e- induced nuclear reactions
 - muon induced nuclear reactions





- Geant4 Physics: Decay, Parameterized and Transportation
 - o decay processes includes:
 - weak decay (leptonic, semi-leptonic decay, radioactive decay of nuclei)
 - electromagnetic decay (π^0 , Σ^0 , etc.)
 - strong decay not included here (they are part of hadronic models)
- parameterized process:
 - EM shower generation based on parameters obtained from averaged events
 - used as fast simulation in case of complex detectors: fast but less accurate
- transportation process:
 - special process that responsible to propagate the particles through the geometry
 - need to be assigned to each particle

PHYSICS PROCESS INTERFACE

- Overview of Geant4 physics components
- The Geant4 physics process interface(es)
- G4VProcess interface and its specialisations
- Secondary particle production thresholds
- What is it? Why do we need them?
- An example.
- Production cuts per region.



Physics Process Interface



- Geant4 propagates G4Track objects in a step-by-step way
- A G4Track objects is a snapshot of the particle state
 - with *dynamic* particle properties G4DynamicParticle (energy, position, etc.)
 - and *static* particle properties G4ParticleDefinition (charge, rest mass, etc.)
 - there are as many G4ParticleDefinition objects as particles constructed (i.e. one G4Electron, one G4Gamma, etc.)
 - but many G4Track objects might represent the same particle type (i.e. many electron tracks with different energy, position, etc.)
- The possible interactions depend (primarily) on the particle type
- The list of possible interactions of a given particle is declared in the Physics List
- This list is stored in a G4ProcessManager object:
 - each G4ParticleDefinition object (particle) has one process manager
 - that holds a list of G4VProcess objects that has been assigned to the particle

G4

Physics Process Interface

The G4VProcess is:

- o the general Geant4 physics process interface to describe any interactions
- at each step, each interaction must provide information such as:
 - How far(space/time) this particle goes till the next interaction of the given type ?
 - What happens in the interaction ? (post interaction primary state + secondaries)
- G4VProcess provides *interface methods* for this information flow:
 - GetPhysicalInteractionLength() to provide the interaction length
 - Dolt() to perform the transformation from the pre- to the post-interaction state
- in general, the particle can interact with matter:
 - AlongStep continuously, while moves from the pre- to the post-step point
 - PostStep at the discrete post-step point of the step (well-located in space)
 - AtRest when it stopes (*well-located in time*)
- for each form of the above interactions, the process needs to implement both the corresponding GetPhysicalInteractionLength() and DoIt() methods
- o a process might be the combination of some or all of the above(6 methods)

Physics Process Interface: example processes



- Discrete process: Compton scattering
 - length of the step to the interaction determined by cross section and the interaction happens at the <u>post-step point</u>
 - <u>PostStepGetPhysicalInteractionLength()</u> and <u>PostStepDoIt()</u>
- Continuous process: Cherenkov effect
 - photons are created <u>along the step</u> (# proportional to the step length)
 - AlongStepGetPhysicalInteractionLength() and <u>AlongStepDoIt()</u>
- At-Rest process: muon minus capture at rest
 - o muon has already stopped (zero kinetic energy) so time is the relevant
 - AtRestGetPhysicalInteractionLength() and <u>AtRestDoIt()</u>
- Continuous + Discrete process: bremsstrahlung (ionization)
 - low energy photons (electrons) are not generated, the corresponding energy loss is deposited along the step as <u>continuous</u> process
 - o energetic photons (electrons) are generated in discrete interaction
 - secondary photon (electron) production threshold separates the two continuous and discrete parts (see later)

Discrete + At-Rest process: positron annihilation

- o in-flight annihilation as a discrete process, determined by the cross section
- at rest annihilation, when the positron has already stopped

Physics Process Interface: process management



- Many processes (i.e. possible interactions) might be assigned to a given particle
 - e.g. gamma: e+/e- pair-production, Compton scat., photoelectric effect, etc.
 - o particle, process constructions and assignment is declared in the *physics list*
 - each *particle* will store the list of assigned *processes* in its G4ProcessManager
 - the static particle object can be obtained from the track at any time
 - and its *process manager* can provide access to the list of the assigned processes per type:
 - list of discrete, or continuous or at-rest processes assigned to the particle
- each of these processes must follow the G4VProcess process interface:
 - implement the type dependent interaction-length and do-it interface method(s)
- at the pre-step point, each processes assigned to the particle:
 - will be asked to provide its physics-interaction length
 - transportation will also provide its length i.e. distance to the next volume boundary
 - the shortest among these length will be selected
 - it determines the post-step point (without field in case of charged particles)
 - it determines the interaction (i.e. process) that happens in this step
- the track will be transported to the post step point:
 - the DoIt() process interface method(s) will be invoked to perform the interaction(s)
- see more on these later in the special EM processes and stepping lecture

SECONDARY PARTICLE PRODUCTION THRESHOLDS

- Overview of Geant4 physics components
- The Geant4 physics process interface(es)
- G4VProcess interface and its specialisations

Secondary particle production thresholds

- o What is it? Why do we need them?
- An example.
- Production cuts per region.

Bremsstrahlung: DCS for bremsstrahlung photon emission of E = 1 [GeV] e in Si 10^{4}

Secondary production threshold: why?

- o low energy photons (k small) will be emitted with high rate i.e. DCS $\sim 1/k$
- generation and tracking of all these low energy photons would not be feasible (CPU time)
- o but low energy photons has a very small absorption **length** (don't go far)
- so if the detector spacial resolution is worst than this length (i.e. all volume boundaries are further), then the followings are *equivalent*:
 - *a*: generating and tracking these low energy photons till all their energy will be deposited
 - **b**: or just depositing the corresponding energy at the creation point (i.e. at a trajectory point)
- o note, that we think in energy scale at the model level that translates to **length**(spacial) at the transport level
- a secondary production threshold might be introduced (either in energy or length)
 - there is a clear translation from one to the other



 10^{3}

 10^{4}

 10^{3}

 10^{3}

 10^{2}

 10^{1}



 $E_{v}^{cut} = 65 [keV]$

100 GeV

1000

Secondary production threshold: why?

Gamma production threshold:

- secondary photons, with initial energy below a gamma production threshold(k<E_v^{cut}), are not generated
- The corresponding energy is accounted as *CONTINUOUS* energy loss of the primary particle along its trajectory
- this gives the radiative contribution of the (restricted) stopping power (dE/dx): mean energy loss due to sub-threshold photon emissions in unit (path) length

$$\frac{\mathrm{d}E}{\mathrm{d}x}(E, E_{\gamma}^{\mathrm{cut}}, Z) = \mathcal{N} \int_{0}^{E_{\gamma}^{\mathrm{cut}}} k \frac{\mathrm{d}\sigma}{\mathrm{d}k}(E, Z) \mathrm{d}k$$

- e.g. when an electron makes a step with a given length L, one can compute the **mean energy loss** (due to sub-threshold photon emissions) along the step simple as $L \ge \frac{dE}{dx}$ (would be true only if E = const along the step)
- secondary photons, with initial energy above a gamma production threshold(k>E_v^{cut}), are generated (*DISCRETE*)
- the emission rate is determined by the corresponding (restricted) cross section(σ)

$$\sigma(E, E_{\gamma}^{\text{cut}}, Z) = \int_{E_{\gamma}^{\text{cut}}}^{E} \frac{\mathrm{d}\sigma}{\mathrm{d}k}(E, Z) \mathrm{d}k$$



Secondary production threshold: why?



- Same concept applies to ionization with the difference:
 - secondary gamma => secondary e- production threshold
 - absorption length => range
 - Secondary production threshold in energy or length?
 - there is a clear translation from energy to length and vice versa
 - o if production threshold would be given in **energy:**
 - the secondary production threshold will be required in **energy** at the model level
 - but its proper value is determined by spacial variables i.e. target size, length
 - but the same energy will translate to different lengths (absorption length, range) in different materials: a 10 keV gamma has very different absorption length in Pb or in Ar
 - moreover the same energy will translate to different lengths depending on the particle type(gamma => absorption length; e-/e+ => range) even in the same material: range of a 10 keV e- in Si is few micron while the absorption length of a 10 keV gamma in Si is few cm
 - one should set different secondary production energy threshold in different materials by keeping in mind the corresponding lengths that they translates depending on the particle type
 - o easier to use length directly (different values depending on the particle types)

Secondary production threshold: Geant4



- Secondary production thresholds in Geant4:
- are given in length with a default of 1.0 [mm]
- its proper value application dependent (size of the sensitive volume, CPU)
- the user need to provide the proper value(s) in the PhysicsList::SetCuts()
 - Ul command: /run/setCut 0.1 mm or /run/setCutForAGivenParticle e- 0.1 mm
- translated to energies at initialisation depending on material an particle type
- this energy has a minimum value: default 990 [eV] but the user can set it
 - UI command: /cuts/setLowEdge 500 eV
- defined for gamma, e-, e+ and proton secondary particle types
 - gamma production threshold is used in bremsstrahlung
 - ◆ e⁻ production threshold is used in ionization
 - e⁺ production threshold might be used in e-/e+ pair production
 - proton production threshold is used as a kinetic energy threshold for nuclear recoil in case of elastic scattering of *all hadrons and ions*
 - gamma and e⁻ production thresholds might be used (optionally: ApplyCuts()) in all discrete interactions producing such secondaries e.g. Compton, Photoelectric, etc.
- o it's not mandatory to use production thresholds (depends only on the models)
- however, high energy physics simulation would simple not be feasible without

Secondary production threshold: example



Compute the mean of the energy deposit (E_f-E₀) in the target



Geant4 Tutorial at Lund University, Lund (Sweden), 3-7 September 2018

Secondary production threshold: Geant4

Final remarks:

- instead of "secondary production threshold length" it's more convenient to say simple "production cut" or even just "cut(s)"
- secondary production cut and tracking cut are two different concepts:
 - production cut applies to secondary particles in their production
 - tracking cut, as a kinetic energy limit, applies to particles already under transportation
- o by default, Geant4 do not need to use tracking cuts
- o however:
 - the user can introduce and define *tracking cuts* for particles (in energy, time, etc.)
 - there is a low energy *tracking limit* applied to *charged particles* (having the special continuous-discrete energy loss process) with a default value of 100 [eV] 1 [keV]
 - was introduced in Geant4.10.2 purely from performance reasons
 - can be set by the user to any value (even to 0) with the following UI command: process/em/lowestElectronEnergy 0.1 eV
- in case of complex detectors (e.g. ATLAS, CMS) there are very different spacial granularities of the different parts of the detector with different sensitivities
- a single production cut value might not be the appropriate one everywhere
- Geant4 provides the possibility to define detector G4Regions with volumes of having similar sensitivity and granularity
- o a different set of secondary production threshold can be defined for each region





Summarv

- Processes describe all the details of interactions
- Geant4 provides processes to cover nearly all particles over a wide energy range from 0 to ~TeV
 - o user might implement and use their own processes as well
- Many processes might be assigned to a given particle
- Secondary production cuts are essential in high energy simulation
- Setting the proper production thresholds essential to get appropriate simulation results
- Geant4 provides the possibility to set proper production thresholds in length for several particles even in the case of the most complex detectors